## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10589143	DEMENTIEVA ET AL.
Examiner	Art Unit
JaNa Hines	1645

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STIC search, inventor searcch, related apps, commerical databases, west cluster, biotech cluster, epo, japio, wpids, caplus, hcaplus, derwent, STN/CAS files, text word search comprising claim language words,	2/2009	JAH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
		1	

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